## **Power MOSFET** 30 V, 14.8 A, N-Channel, SO-8

#### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- This is a Pb-Free Device

### Applications

- Disk Drives
- DC-DC Converters
- Printers

#### MAXIMUM RATINGS (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

MAAIMOW RATINGS	(1) = 20 0		· · · · ·	1	
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	30	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	12.2	А
Current R <sub>0JA</sub> (Note 1)		T <sub>A</sub> = 70°C		9.8	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	1.55	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	9.1	А
Current R <sub>0JA</sub> (Note 2)	Steady	T <sub>A</sub> = 70°C		7.3	
Power Dissipation $R_{\theta JA}$ (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	0.86	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	14.8	А
Current $R_{\theta JA}$ , t $\leq$ 10 s (Note 1)		T <sub>A</sub> = 70°C		11.8	
Power Dissipation $R_{\theta JA}$ , t $\leq$ 10 s(Note 1)		$T_A = 25^{\circ}C$	P <sub>D</sub>	2.3	W
Pulsed Drain Current	Pulsed Drain Current $T_A = 25^{\circ}C, t_p = 10 \mu s$			50	А
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C
Source Current (Body Diode)			۱ <sub>S</sub>	2.9	А
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 30 V, V <sub>GS</sub> = 10 V, I <sub>L</sub> = 14 A <sub>pk</sub> , L = 1.0 mH, R <sub>G</sub> = 25 $\Omega$ )			E <sub>AS</sub>	98	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	80.5	°C/W
Junction-to-Ambient – $t \le 10 \text{ s}$ (Note 1)	$R_{\theta JA}$	54.9	
Junction-to-Foot (Drain)	$R_{\theta JF}$	19.5	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	145	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surfacemounted on FR4 board using 1 in sq pad size.

2. Surfacemounted on FR4 board using the minimum recommended pad size.

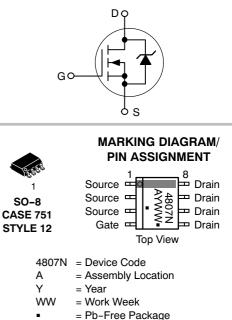


## ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
30 V	6.1 mΩ @ 10 V	14.8 A	
50 V	7.5 mΩ @ 4.5 V	14.0 A	





#### **ORDERING INFORMATION**

(Note: Microdot may be in either location)

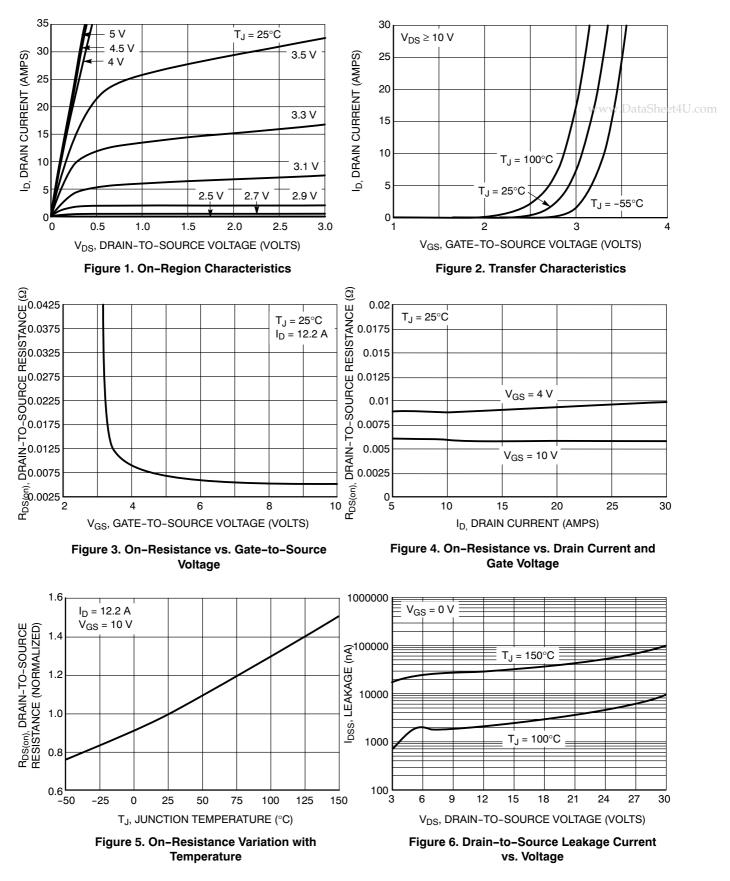
Device	Package	Shipping <sup>†</sup>
NTMS4807NR2G	SO-8 (Pb-Free)	2500/Tape & Reel

+ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

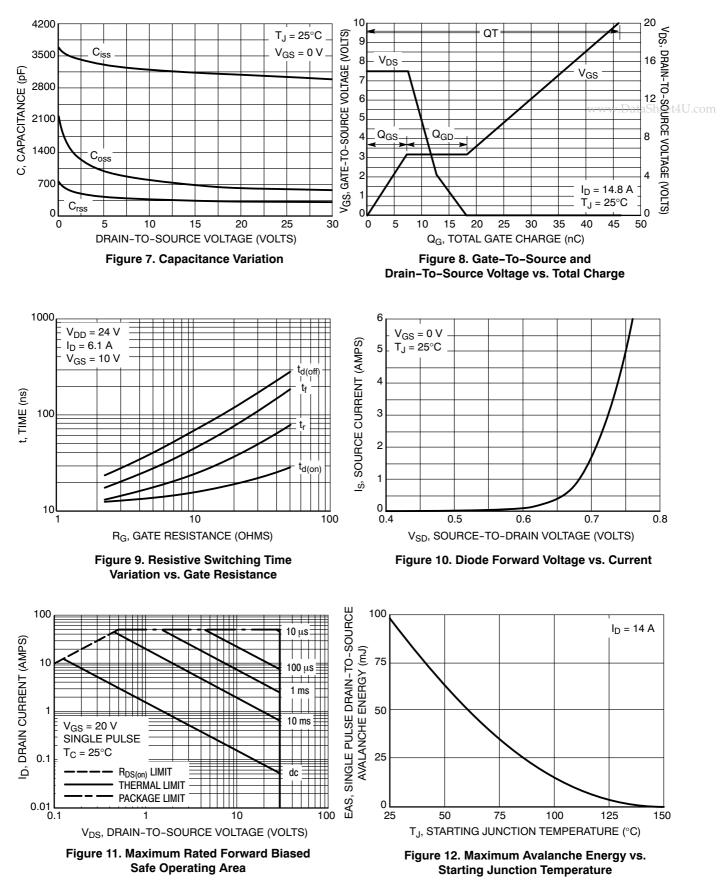
## ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	-	-			-	-	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 $\mu$ A		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				29		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		$T_J = 25^{\circ}C$			WINOW.L	ata <mark>n</mark> hee
		$V_{GS}$ = 0 V, $V_{DS}$ = 24 V	T <sub>J</sub> = 100°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> =	±20 V			±100	nA
ON CHARACTERISTICS (Note 3)	•	•			•	•	
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 2$	250 μA	1.5		3.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				6.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = 10 V, I <sub>D</sub> =	14.8 A		5.1	6.1	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> =	: 12 A		6.5	7.5	
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> =	14.8 A		16		S
CHARGES, CAPACITANCES AND GA	ATE RESISTAN	ICE			•	•	•
Input Capacitance	C <sub>iss</sub>				2900		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz	V <sub>DS</sub> = 24 V		562		_
Reverse Transfer Capacitance	C <sub>rss</sub>				307		-
Total Gate Charge	Q <sub>G(TOT)</sub>				24		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				3.4		
Gate-to-Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V	$V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 14.8 A		7.7		
Gate-to-Drain Charge	Q <sub>GD</sub>				10.4		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V, I <sub>D</sub> = 14.8 A			46		nC
SWITCHING CHARACTERISTICS (No	ote 4)	•			•	•	
Turn-On Delay Time	t <sub>d(on)</sub>				14		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> =	= 15 V.		6.5		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_{\rm D} = 1.0 \text{ A}, \text{ R}_{\rm G} =$	6.0 Ω		47		
Fall Time	t <sub>f</sub>		Ī		17		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>		$T_J = 25^{\circ}C$		0.75	1.0	V
		$V_{GS}$ = 0 V, I <sub>S</sub> = 2.9 A	T <sub>J</sub> = 125°C		0.58		-
Reverse Recovery Time	t <sub>RR</sub>		•		30		ns
Charge Time	t <sub>a</sub>	VGS = 0 V. dis/d+ = -	100 A/us.		15		1
Discharge Time	t <sub>b</sub>	$V_{GS}$ = 0 V, $d_{IS}/d_{t}$ = 100 A/µs, $I_{S}$ = 2.9 A			15		1
Reverse Recovery Charge	Q <sub>RR</sub>				23		nC
PACKAGE PARASITIC VALUES	-	-			-	-	-
Source Inductance	L <sub>S</sub>	T <sub>A</sub> = 25°C			0.66		nH
Drain Inductance	L <sub>D</sub>	T <sub>A</sub> = 25°C			0.20		nH
Gate Inductance	L <sub>G</sub>	T <sub>A</sub> = 25°C			1.5		nH
Gate Resistance	R <sub>G</sub>	T <sub>A</sub> = 25°C			0.9	1.4	Ω

### **TYPICAL PERFORMANCE CURVES**

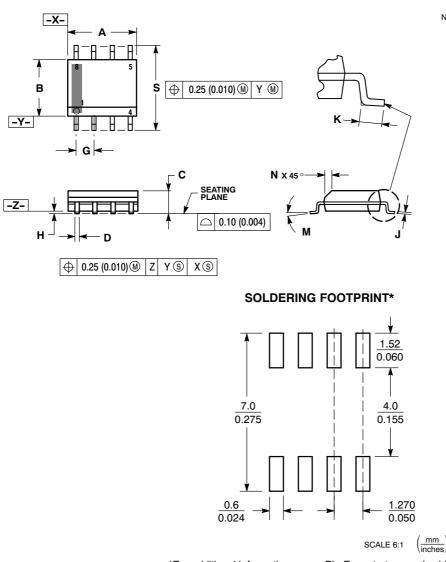


### **TYPICAL PERFORMANCE CURVES**



#### PACKAGE DIMENSIONS

SOIC-8 CASE 751-07 **ISSUE AJ** 



NOTES

- 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER. DIMENSION A AND B DO NOT INCLUDE: taSheet4U.com З. MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) 4. PER SIDE.
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT 5.
- MAXIMUM MATERIAL CONDITION. 751-01 THRU 751-06 ARE OBSOLETE. NEW 6. STANDARD IS 751-07.

	MILLIN	IETERS	INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	4.80	5.00	0.189	0.197	
в	3.80	4.00	0.150	0.157	
С	1.35	1.75	0.053	0.069	
D	0.33	0.51	0.013	0.020	
G	1.27 BSC		0.050 BSC		
н	0.10	0.25	0.004	0.010	
J	0.19	0.25	0.007	0.010	
ĸ	0.40	1.27	0.016	0.050	
м	0 °	8 °	0 °	8 °	
Ν	0.25	0.50	0.010	0.020	
S	5.80	6.20	0.228	0.244	

STYLE 12: PIN 1. SOURCE 2. SOURCE

3.	SOURCE
4.	GATE
5.	DRAIN
6.	DRAIN

DRAIN 7.

8. DRAIN

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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